


<b>Search Notes</b>  	<b>Application/Control No.</b>  10529299	<b>Applicant(s)/Patent Under Reexamination</b>  IWANAGA, KAZUHIKO
	<b>Examiner</b>  WILSON TSUI	<b>Art Unit</b>  2178

SEARCHED			
Class	Subclass	Date	Examiner
715	243, 249, 247, 246, 251, 255	11/19/09	/WT/

SEARCH NOTES		
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East Search: USPAT, USPGPUB .... See notes	11/19/09	/WT/
Google Scholar: Keywords: content fitting layout	11/19/09	/WT/

INTERFERENCE SEARCH			
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Examiner.Art Unit 2178